# **Power MOSFET**

-30 V, -1.95 A, Single, P-Channel, SOT-23

# **Features**

- Leading Planar Technology for Low Gate Charge/Fast Switching
- Low R<sub>DS(ON)</sub> for Low Conduction Losses
- SOT-23 Surface Mount for Small Footprint (3 x 3 mm)
- NV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

# **Applications**

- DC to DC Conversion
- Load/Power Switch for Portables and Computing
- Motherboard, Notebooks, Camcorders, Digital Camera's, etc.
- Battery Charging Circuits

# **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	-30	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Drain Current (Note 1)	t < 10 s T <sub>A</sub> = 25°C		I <sub>D</sub>	-1.95	Α
		T <sub>A</sub> = 70°C		-1.56	
Power Dissipation (Note 1)	t < 10 s		$P_{D}$	1.25	W
Continuous Drain Current (Note 1)	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	-1.13	Α
(Note 1)	State	T <sub>A</sub> = 70°C		-0.90	
Power Dissipation (Note 1)	Stead	dy State	P <sub>D</sub>	0.4	W
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	-6.8	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>STG</sub>	–55 to 150	°C
Source Current (Body Diode)			IS	-1.25	Α
Lead Temperature for Soldering Purposes (1/8 in from case for 10 s)			TL	260	°C

#### THERMAL RESISTANCE RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	300	°C/W
Junction-to-Ambient - t = 10 s (Note 1)	$R_{ hetaJA}$	100	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted on FR4 board using 1 in sq. pad size (Cu area = 1.127 in sq. [1 oz] including traces).

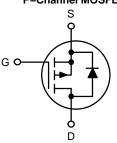


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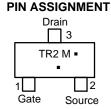
V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> Max (Note 1)	
-30 V	155 mΩ @ –10 V	4.05.4	
	240 mΩ @ -4.5 V	–1.95 A	

#### P-Channel MOSFET





# SOT-23 CASE 318 STYLE 21



MARKING DIAGRAM/

TR2 = Device Code
M = Date Code\*

= Pb-Free Package

(Note: Microdot may be in either location)

\*Date Code orientation and/or overbar may vary depending upon manufacturing location.

### ORDERING INFORMATION

Device	Package	Shipping†
NTR4502PT1G	SOT-23 (Pb-Free)	3000 / Tape & Reel
NVTR4502PT1G	SOT-23 (Pb-Free)	3000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

# **Electrical Characteristics** (T<sub>J</sub> = 25°C unless otherwise specified)

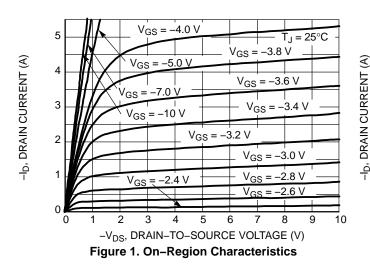
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$		-30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = -30 \text{ V}$	T <sub>J</sub> = 25°C			-1	μΑ
			T <sub>J</sub> = 55°C			-10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20$	) V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{D} = -250$	μΑ	-1.0		-3.0	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = -10 \text{ V}, I_D = -1.95 \text{ A}$			155	200	mΩ
		$V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ V}$	.5 A		240	350	
Forward Transconductance	9FS	$V_{DS} = -10 \text{ V}, I_{D} = -1.25 \text{ A}$			3		S
CHARGES AND CAPACITANCES						-	
Input Capacitance	C <sub>ISS</sub>	$V_{GS} = 0 \text{ V, f} = 1 \text{ MHz, } V_{DS} = -15 \text{ V}$			200		pF
Output Capacitance	C <sub>OSS</sub>				80		
Reverse Transfer Capacitance	C <sub>RSS</sub>				50		
Total Gate Charge	$Q_{G(TOT)}$	$V_{GS} = -10 \text{ V}, V_{DS} = -15 \text{ V}; I_D = -1.95 \text{ A}$			6	10	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				0.3		
Gate-to-Source Charge	$Q_GS$				1		
Gate-to-Drain Charge	$Q_{GD}$				1.7		
SWITCHING CHARACTERISTICS (Note 4	)					-	
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -10 \text{ V}, V_{DD} = -1 $ $I_D = -1.95 \text{ A}, R_G = 6$	5 V,		5.2	10	ns
Rise Time	t <sub>r</sub>	$I_D = -1.95 \text{ A}, R_G = 6 \Omega$			12	20	1
Turn-Off Delay Time	t <sub>d(OFF)</sub>				19	35	1
Fall Time	t <sub>f</sub>			17.5	30	1	
DRAIN-SOURCE DIODE CHARACTERIS	TICS (Note 3)						
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V, } I_{S} = -1.25 \text{ A}$			-0.8	-1.2	V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V}, dI_{SD}/d_t = 100 \text{ A/}\mu\text{s}, I_S = -1.25 \text{ A}$			23		ns

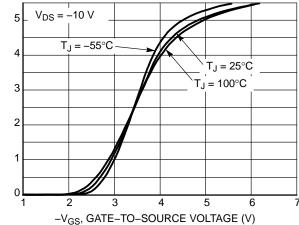
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

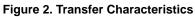
2. Surface–mounted on FR4 board using 1 in sq. pad size (Cu area = 1.127 in sq. [1 oz] including traces).

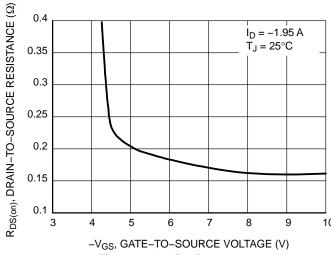
3. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

4. Switching characteristics are independent of operating junction temperatures.









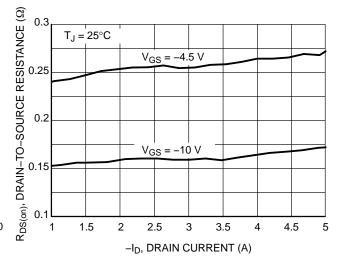
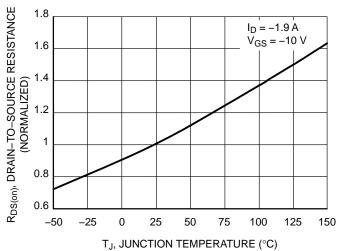


Figure 3. On–Resistance versus Gate–to–Source Voltage

Figure 4. On–Resistance versus Drain Current and Gate Voltage



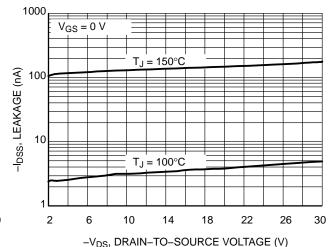


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current versus Voltage

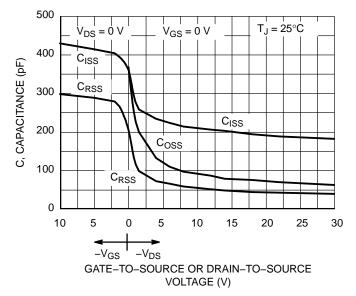


Figure 7. Capacitance Variation

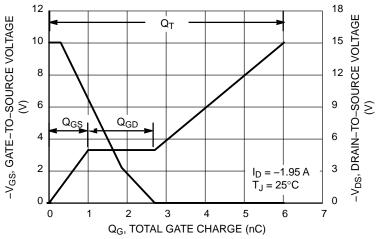


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

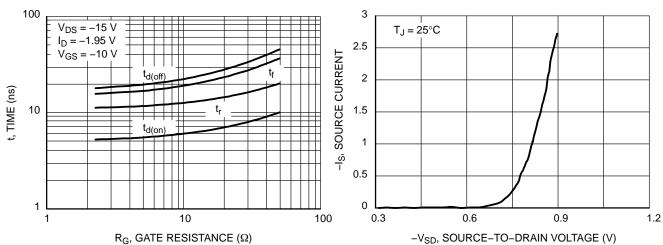
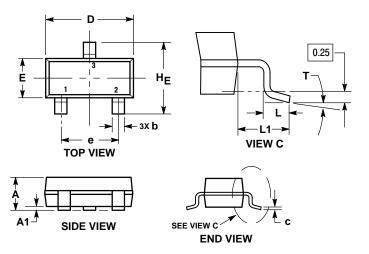


Figure 9. Resistive Switching Time Variation versus Gate Resistance

Figure 10. Diode Forward Voltage versus Current

#### PACKAGE DIMENSIONS

# SOT-23 (TO-236) CASE 318-08 **ISSUE AR**



- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF
- THE BASE MATERIAL.

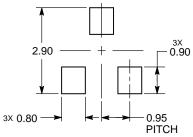
  DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH,
  PROTRUSIONS, OR GATE BURRS.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.89	1.00	1.11	0.035	0.039	0.044
A1	0.01	0.06	0.10	0.000	0.002	0.004
b	0.37	0.44	0.50	0.015	0.017	0.020
С	0.08	0.14	0.20	0.003	0.006	0.008
D	2.80	2.90	3.04	0.110	0.114	0.120
E	1.20	1.30	1.40	0.047	0.051	0.055
е	1.78	1.90	2.04	0.070	0.075	0.080
L	0.30	0.43	0.55	0.012	0.017	0.022
L1	0.35	0.54	0.69	0.014	0.021	0.027
HE	2.10	2.40	2.64	0.083	0.094	0.104
Т	0°		10°	0°		10°

#### STYLE 21:

- PIN 1. GATE
  - SOURCE 2.
  - DRAIN

# **RECOMMENDED** SOLDERING FOOTPRINT\*



**DIMENSIONS: MILLIMETERS** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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